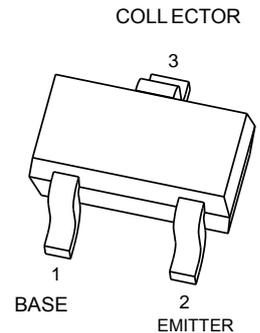




2SC5066 VHF~UHF Band Low Noise Amplifier Applications

- Low noise figure, high gain.
- $NF = 1.1\text{dB}$, $|S_{21e}|^2 = 12\text{dB}$ ($f = 1\text{GHz}$)

Marking : 2SC5066O M1
2SC5066Y M2



Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

| Characteristics | Symbol | Rating | Unit |
|-----------------------------|-----------|------------|------------------|
| Collector-base voltage | V_{CB0} | 20 | V |
| Collector-emitter voltage | V_{CEO} | 12 | V |
| Emitter-base voltage | V_{EBO} | 3 | V |
| Base current | I_B | 15 | mA |
| Collector current | I_C | 30 | mA |
| Collector power dissipation | P_C | 100 | mW |
| Junction temperature | T_j | 125 | $^\circ\text{C}$ |
| Storage temperature range | T_{stg} | -55 to 125 | $^\circ\text{C}$ |

SOT-523

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Microwave Characteristics ($T_a = 25^\circ\text{C}$)

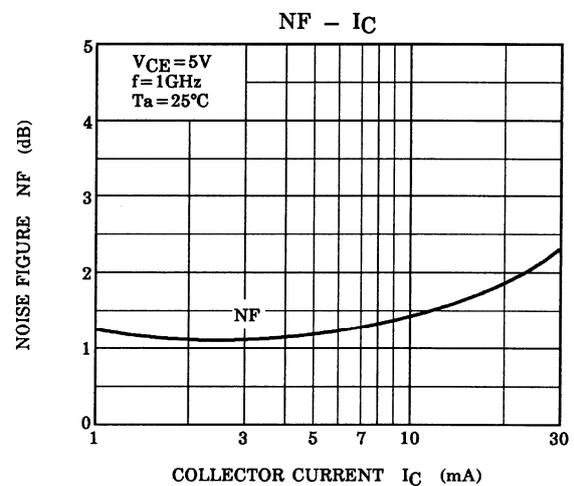
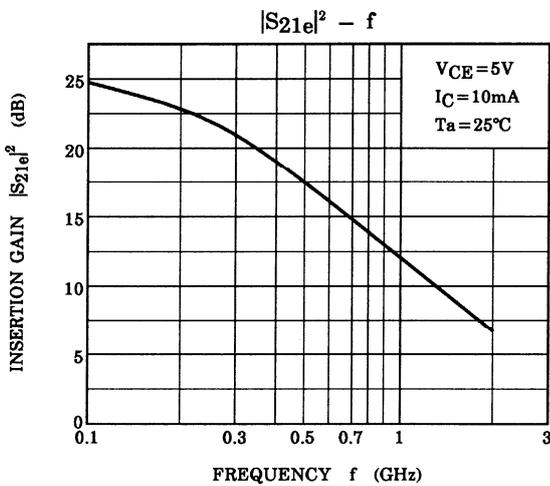
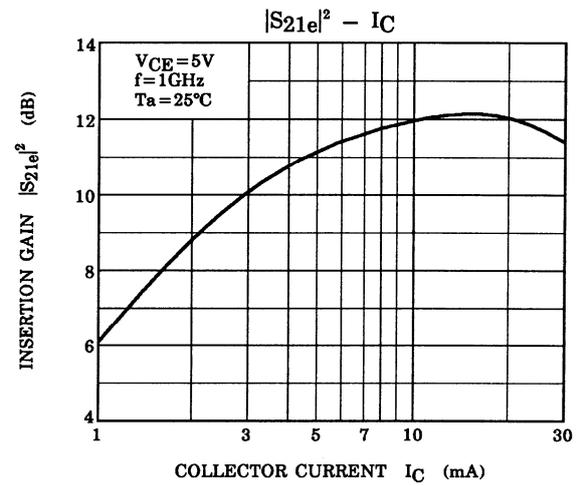
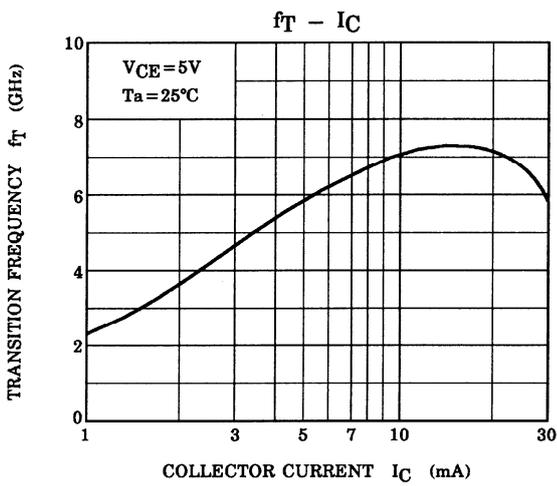
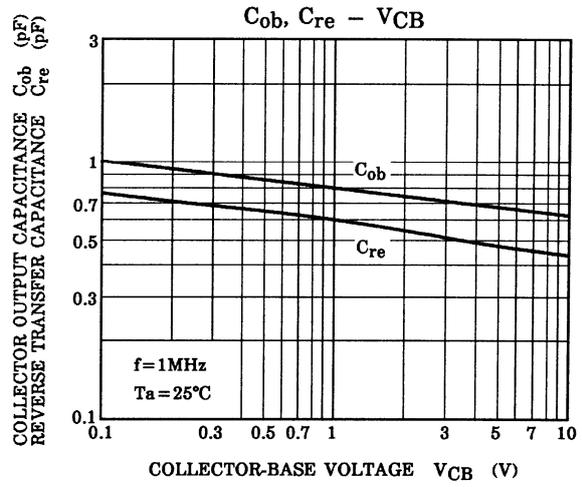
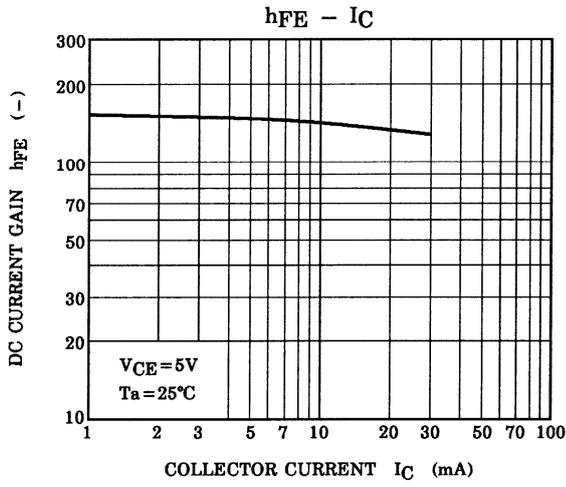
| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|----------------------|-------------------|--|-----|------|-----|------|
| Transition frequency | f_T | $V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$ | 5 | 7 | — | GHz |
| Insertion gain | $ S_{21e} ^2$ (1) | $V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$, $f = 500\text{MHz}$ | — | 17 | — | dB |
| | $ S_{21e} ^2$ (2) | $V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$, $f = 1\text{GHz}$ | 8.5 | 12 | — | |
| Noise figure | NF (1) | $V_{CE} = 5\text{V}$, $I_C = 3\text{mA}$, $f = 500\text{MHz}$ | — | 1 | — | dB |
| | NF (2) | $V_{CE} = 5\text{V}$, $I_C = 3\text{mA}$, $f = 1\text{GHz}$ | — | 1.1 | 2.0 | |

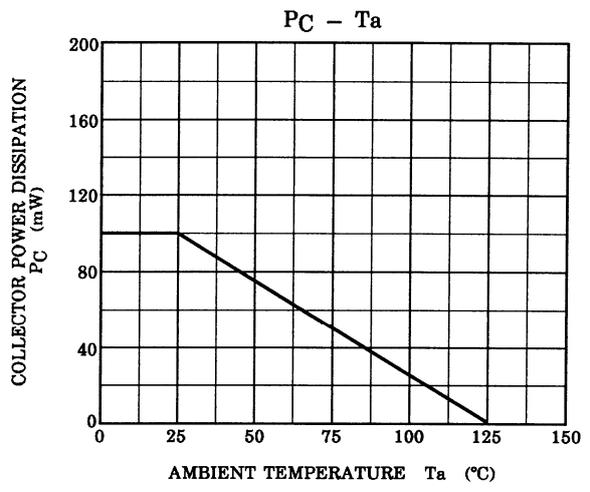
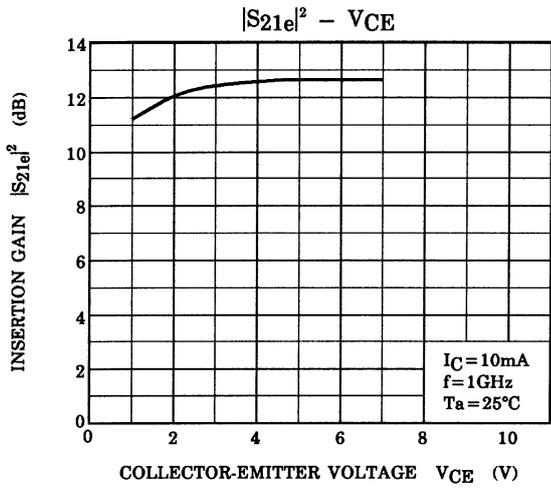
Electrical Characteristics ($T_a = 25^\circ\text{C}$)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|------------------------------|----------------------|---|-----|------|-----|---------------|
| Collector cut-off current | I_{CB0} | $V_{CB} = 10\text{V}$, $I_E = 0$ | — | — | 1 | μA |
| Emitter cut-off current | I_{EBO} | $V_{EB} = 1\text{V}$, $I_C = 0$ | — | — | 1 | μA |
| DC current gain | h_{FE} (Note 1) | $V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$ | O | 80 | — | 160 |
| | | | Y | 120 | — | 240 |
| Output capacitance | C_{ob} | $V_{CB} = 5\text{V}$, $I_E = 0$, $f = 1\text{MHz}$ (Note 2) | — | 0.7 | — | pF |
| Reverse transfer capacitance | C_{re} | | — | 0.45 | 0.9 | pF |

Note 1: h_{FE} classification O: 80 to 160, Y: 120 to 240

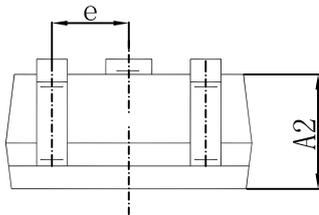
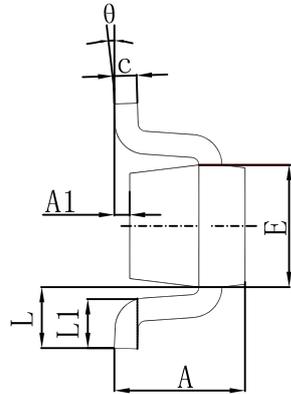
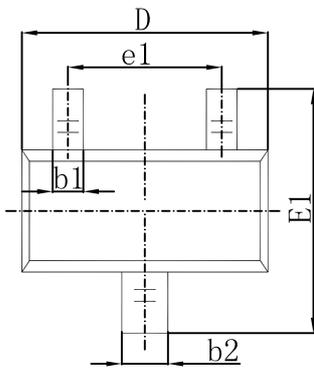
Note 2: C_{re} is measured by 3 terminal method with capacitance bridge.





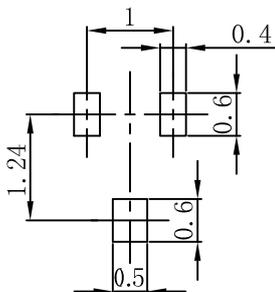


SOT-523 Package Outline Dimensions



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 0.700 | 0.900 | 0.028 | 0.035 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 0.700 | 0.800 | 0.028 | 0.031 |
| b1 | 0.150 | 0.250 | 0.006 | 0.010 |
| b2 | 0.250 | 0.350 | 0.010 | 0.014 |
| c | 0.100 | 0.200 | 0.004 | 0.008 |
| D | 1.500 | 1.700 | 0.059 | 0.067 |
| E | 0.700 | 0.900 | 0.028 | 0.035 |
| E1 | 1.450 | 1.750 | 0.057 | 0.069 |
| e | 0.500 TYP. | | 0.020 TYP. | |
| e1 | 0.900 | 1.100 | 0.035 | 0.043 |
| L | 0.400 REF. | | 0.016 REF. | |
| L1 | 0.260 | 0.460 | 0.010 | 0.018 |
| θ | 0° | 8° | 0° | 8° |

SOT-523 Suggested Pad Layout



Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.